ocument Number: STCV271K0CY4\
Preliminary Datasheet V1.2

## Gallium Nitride 50V, 1000W, 2.5-2.7GHz RF Power Transistor

### **Description**

The STCV271K0CY4V is a 1000-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 2.5-2.7GHz, **enabled by wide band VBW capability to support IBW up to 200MHz.**.

It can be configured as asymmetrical Doherty for 4G or 5G application, delivering 115 to 140W average power, according to normal 9.5 to 8.5dB back off.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

• Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance within **2.5-2.7GHz**: VDD = 50 Vdc, IDQA = 260 mA, VGSB = -5.3Vdc,

1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.

Frog	Pulse CW Signal <sup>(1)</sup>			P <sub>avg</sub> =50.5dBm WCDMA Signal <sup>(2)</sup>			
Freq (GHz)	Р3	Р3	P4	P4	(	aa (0/)	ACDD (dDa)
(0112)	(dBm)	(W)	(dBm)	(W)	Gp (dB)	η <sub>D</sub> (%)	ACPR <sub>5M</sub> (dBc)
2.50	59.52	897	60.36	1085	13.63	51.35	-30.40
2.60	60.12	1028	60.45	1109	13.37	51.39	-31.29
2.70	59.90	976	60.05	1011	12.80	51.98	-29.09

• Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance within **2.62-2.69GHz**: VDD = 50 Vdc, IDQA = 260 mA, VGSB = -5.3Vdc,

1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.

Frog	Pulse CW Signal <sup>(1)</sup>			P <sub>avg</sub> =50.5dBm WCDMA Signal <sup>(2)</sup>			
Freq (GHz)	Р3	Р3	P4	P4	C 2 (4D)	on (0/)	ACPR <sub>5M</sub> (dBc)
(0112)	(dBm)	(W)	(dBm)	(W)	Gp (dB)	η <sub>D</sub> (%)	
2.62	59.7	920	60.15	1035	13.03	52.30	-31.31
2.655	59.53	900	60.08	1018	12.80	52.61	-29.83
2.69	59.53	900	60.02	1005	12.78	52.50	-28.56

#### Driver options:

STAV27130C6 (1 stage Doherty discrete)

#### **Applications**

- Asymmetrical Doherty amplifier within N41 5G band and B41 4G band
- S band power amplifier

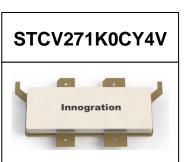
#### **Important Note: Proper Biasing Sequence for GaN HEMT Transistors**

#### Turning the device ON

- 1. Set VGS to the pinch—off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

#### Turning the device OFF

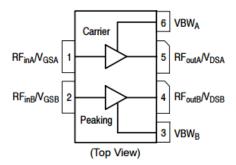
- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS



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Figure 1: Pin Connection definition



**Table 1. Maximum Ratings** 

Rating	Symbol	Value	Unit
Drain—Source Voltage	V <sub>DSS</sub>	+200	Vdc
Gate—Source Voltage	$V_{GS}$	-8 to +0.5	Vdc
Operating Voltage	V <sub>DD</sub>	55	Vdc
Maximum gate current	Igs	131	mA
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature	TJ	+225	°C

#### **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA	Rejc	TBD	°C /W
T <sub>C</sub> = 85°C, Pout=120W, 2.6GHz Doherty application board	KAJC	180	C/VV

#### Table 3. Electrical Characteristics (TA = 25℃ unless otherwise noted)

#### DC Characteristics (main path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=47mA	V <sub>DSS</sub>		200		V
Gate Threshold Voltage	VDS =10V, ID = 47mA	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=240mA, Measured in Functional Test	$V_{GS(Q)}$		-3.1		V

#### DC Characteristics (peak path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=84mA	V <sub>DSS</sub>		200		V
Gate Threshold Voltage	VDS =10V, ID = 84mA	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=400mA Measured in Functional Test	$V_{GS(Q)}$		-3.1		V

#### **Ruggedness Characteristics**

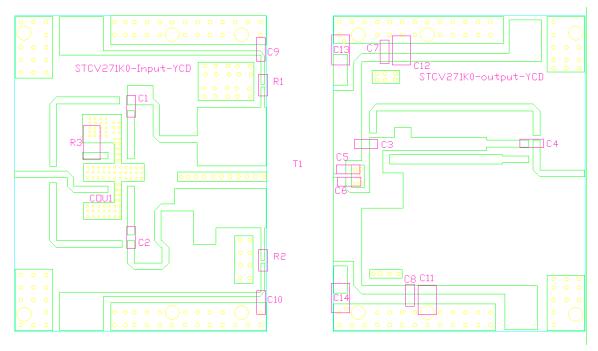
Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Load mismatch capability	2.6GHz, Pout=120W WCDMA 1					
	Carrier in Doherty circuit	VSWR		10:1		
	All phase,	VSVVK		10.1		
	No device damages					



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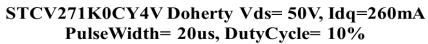
Figure 3: Picture of application board Doherty circuit for 2.5-2.7GHz



Part	Quantity	Description	Part Number	Manufacture
C1,C2	7	10pFHigh Q	251SHS100BSE	TEMEX
C4,C7,C8,C9,C10		Capacitor		
C3	1	3.9pFHigh Q	251SHS3R9BSE	TEMEX
		Capacitor		
C5	1	1.3pFHigh Q	251SHS1R3BSE	TEMEX
		Capacitor		
C6	1	1.1pFHigh Q	251SHS1R1BSE	TEMEX
		Capacitor		
C11,C12,C13,C14	4	10uF MLCC	RS80R2A106M	MARUWA
R1,R2	2	10 $\Omega$ Power	ESR03EZPF100	ROHM
		Resistor		
R3	1	51 $\Omega$ Power	RFR50-20CT0421B	YT
		Resistor		
COU1	1	3 dB Bridge	X3C26P1-03S	Anaren
T1	1	1000W GaN	STCV271K0CY4V	Innogration
		Dual Transistor		

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Figure 4: Efficiency and power gain as function of Pout



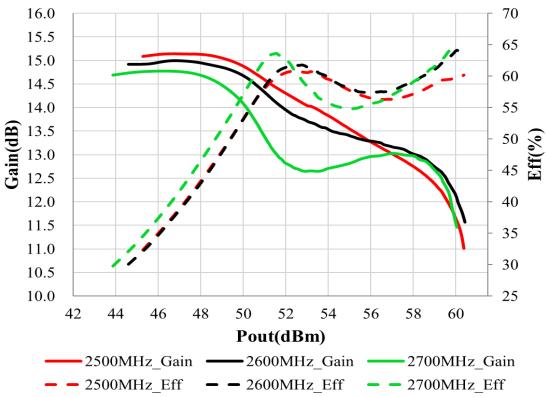
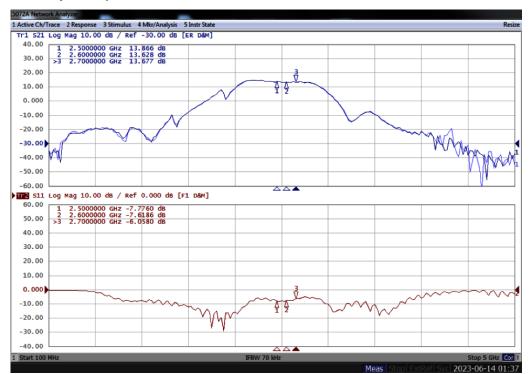
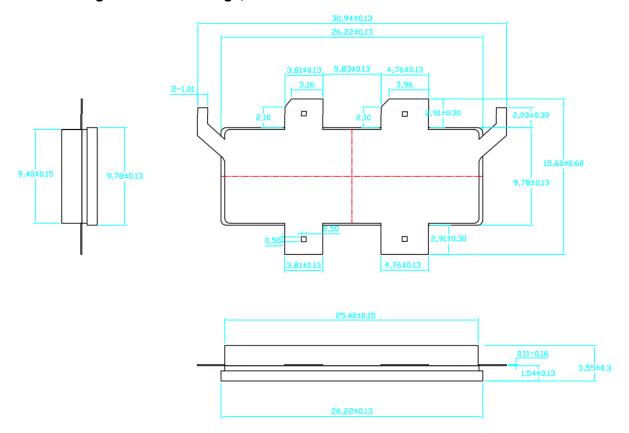


Figure 5: Network analyzer output, S11 and S21



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### Earless Flanged Ceramic Package; 6 leads- CY4V



### **Revision history**

**Table 4. Document revision history** 

Date	Revision	Datasheet Status
2023/5/12	V1.0	Objective Datasheet Creation
2023/6/16	V1.0	Preliminary Datasheet Creation
2024/12/26	V1.1	Modify typo of P3 info for 2.62-2.69GHz on 1st page

Application data based on LWH-23-14/15/18

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